

**Notic of R ferenc s Cited**

Application/Control No.

10/073,693

Applicant(s)/Patent Under  
Reexamination  
PARK ET AL.

Examiner

Sin J Lee

Art Unit

1752

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0009666 A1	01-2002	Sato et al.	430/270.1
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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